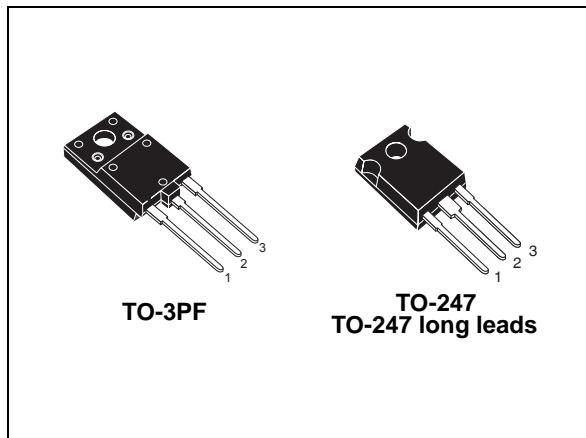


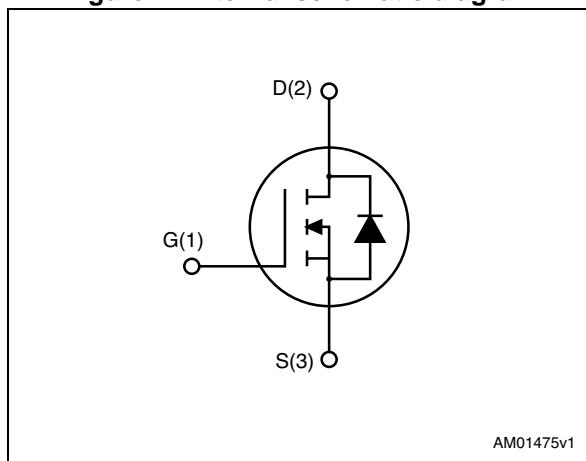
# STFW45N65M5, STW45N65M5, STWA45N65M5

N-channel 650 V, 35 A, 0.067  $\Omega$  typ., MDmesh™ V Power MOSFETs  
in TO-3PF, TO-247 and TO-247 long leads packages

Datasheet - production data



**Figure 1. Internal schematic diagram**



## Features

Order codes	$V_{DS}$ @ $T_{Jmax}$	$R_{DS(on)}$ max	$I_D$
STFW45N65M5	710 V	0.078 $\Omega$	35 A
STW45N65M5			
STWA45N65M5			

- Worldwide best  $R_{DS(on)}$  \* area
- Higher  $V_{DSS}$  rating and high dv/dt capability
- Excellent switching performance
- 100% avalanche tested

## Applications

- Switching applications

## Description

These devices are N-channel MDmesh™ V Power MOSFETs based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low on-resistance, which is unmatched among silicon-based Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

**Table 1. Device summary**

Order codes	Marking	Package	Packaging
STFW45N65M5	45N65M5	TO-3PF	Tube
STW45N65M5		TO-247	
STWA45N65M5		TO-247 long leads	

## Contents

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# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value		Unit
		TO-3PF	TO-247, TO-247 long leads	
$V_{GS}$	Gate-source voltage	$\pm 25$		V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	35		A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	22		A
$I_{DM}^{(1)}$	Drain current (pulsed)	140		A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	57	210	W
$dv/dt^{(2)}$	Peak diode recovery voltage slope	15		V/ns
$dv/dt^{(3)}$	MOSFET dv/dt ruggedness	50		V/ns
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t=1\text{ s}$ ; $T_c=25^\circ\text{C}$ )	3500		V
$T_{stg}$	Storage temperature	- 55 to 150		$^\circ\text{C}$
$T_j$	Max. operating junction temperature	150		$^\circ\text{C}$

1. Limited by maximum junction temperature
2.  $I_{SD} \leq 35\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ,  $V_{DS(\text{Peak})} < V_{(\text{BR})\text{DSS}}$ ,  $V_{DD} = 400\text{ V}$
3.  $V_{DS} < 520\text{ V}$

Table 3. Thermal data

Symbol	Parameter	Value		Unit
		TO-3PF	TO-247, TO-247 long leads	
$R_{thj-case}$	Thermal resistance junction-case max	2.2	0.6	$^\circ\text{C}/\text{W}$
$R_{thj-amb}$	Thermal resistance junction-ambient max	50	50	$^\circ\text{C}/\text{W}$

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )	9	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j=25^\circ\text{C}$ , $I_d=I_{AR}$ ; $V_{dd}=50$ )	810	mJ

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified)

**Table 5. On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	650			V
$I_{\text{DSS}}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 650 \text{ V}$			1	$\mu\text{A}$
		$V_{DS} = 650 \text{ V}, T_C = 125^\circ\text{C}$			100	$\mu\text{A}$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 25 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{DS(\text{on})}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 17.5 \text{ A}$		0.067	0.078	$\Omega$

**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$	-	3470	-	pF
$C_{oss}$	Output capacitance		-	82	-	pF
$C_{rss}$	Reverse transfer capacitance		-	7	-	pF
$C_{o(\text{tr})}^{(1)}$	Equivalent capacitance time related	$V_{DS} = 0 \text{ to } 520 \text{ V}, V_{GS} = 0$	-	280	-	pF
$C_{o(\text{er})}^{(2)}$	Equivalent capacitance energy related		-	79	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz open drain}$	-	2	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 17.5 \text{ A}, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 18</a> )	-	82	-	nC
$Q_{gs}$	Gate-source charge		-	18.5	-	nC
$Q_{gd}$	Gate-drain charge		-	35	-	nC

1. Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$
2. Energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 7. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max	Unit
$t_d(v)$	Voltage delay time	$V_{DD} = 400 \text{ V}$ , $I_D = 23 \text{ A}$ , $R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 19</a> and <a href="#">Figure 22</a> )	-	79.5	-	ns
$t_r(v)$	Voltage rise time		-	11	-	ns
$t_f(i)$	Current fall time		-	9.3	-	ns
$t_c(\text{off})$	Crossing time		-	16	-	ns

**Table 8. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		35	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		140	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 35 \text{ A}$ , $V_{GS} = 0$	-		1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 35 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 100 \text{ V}$ (see <a href="#">Figure 19</a> )	-	392		ns
$Q_{rr}$	Reverse recovery charge		-	7.4		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	38		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 35 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 100 \text{ V}$ , $T_j = 150^\circ\text{C}$ (see <a href="#">Figure 19</a> )	-	468		ns
$Q_{rr}$	Reverse recovery charge		-	9.7		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	42		A

1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-3PF

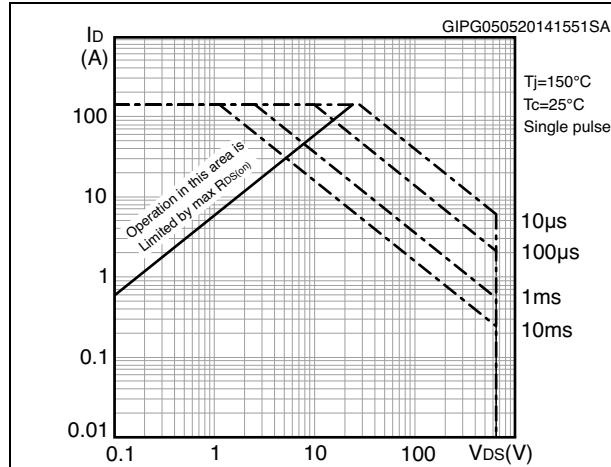


Figure 3. Thermal impedance for TO-3PF

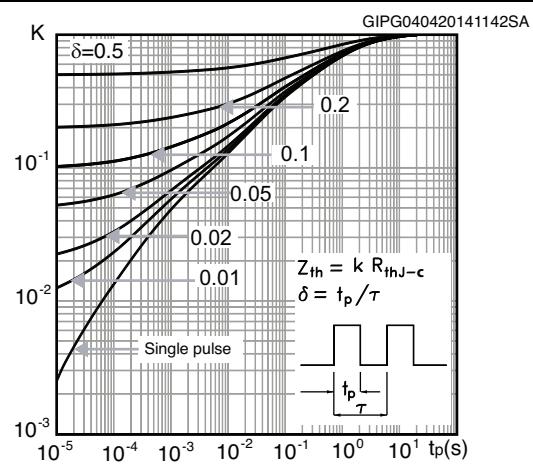


Figure 4. Safe operating area for TO-247 and TO-247LL

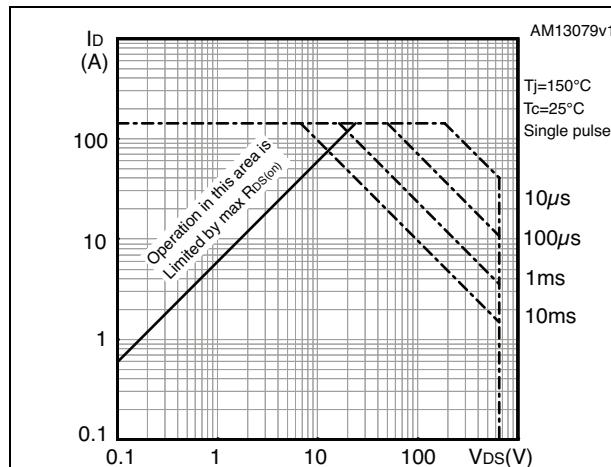


Figure 5. Thermal impedance for TO-247 and TO-247LL

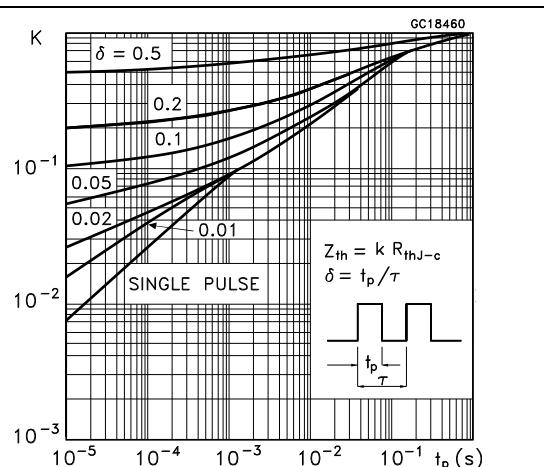


Figure 6. Output characteristics

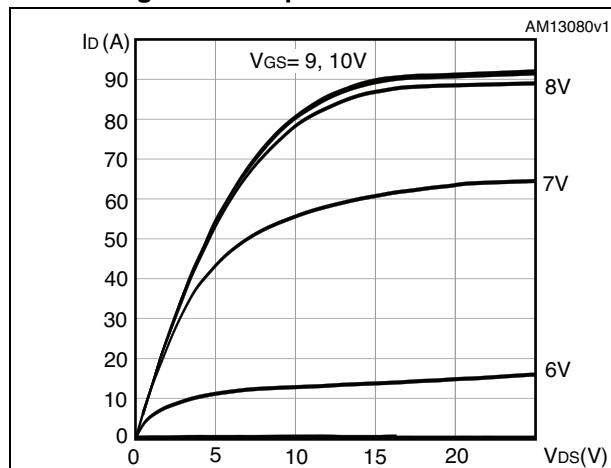
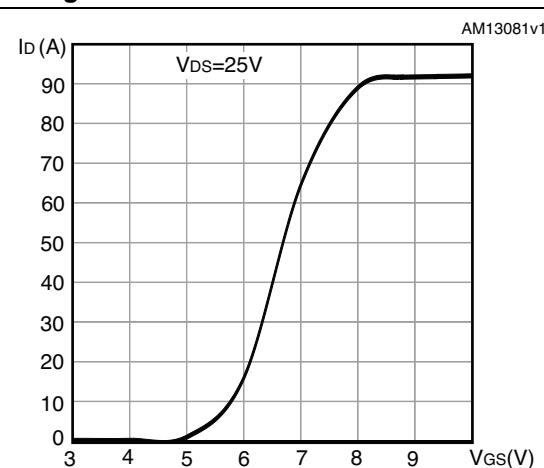
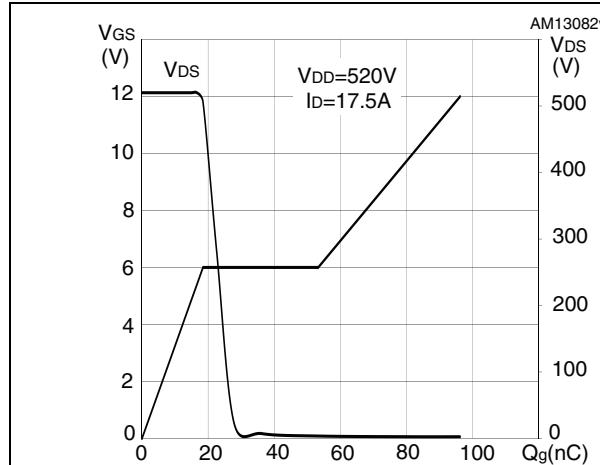
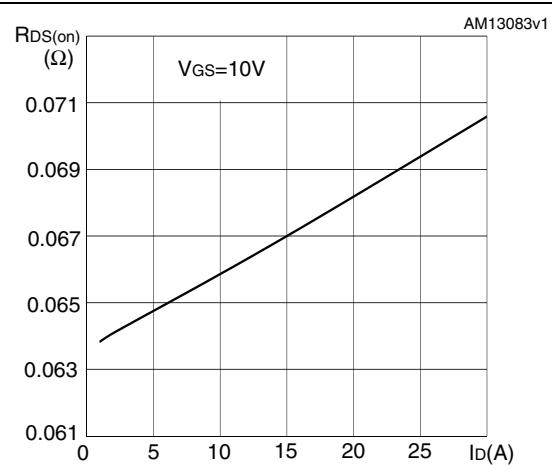
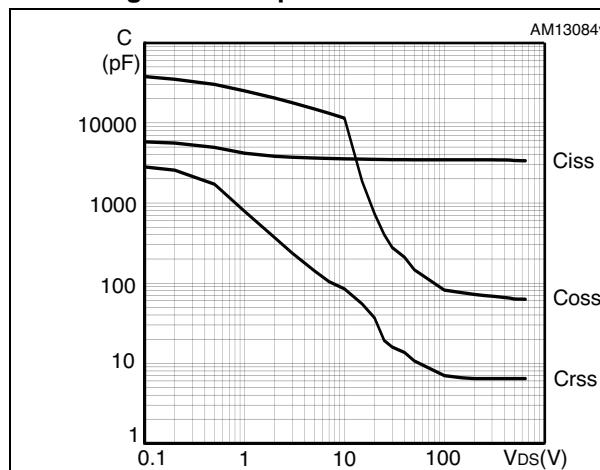
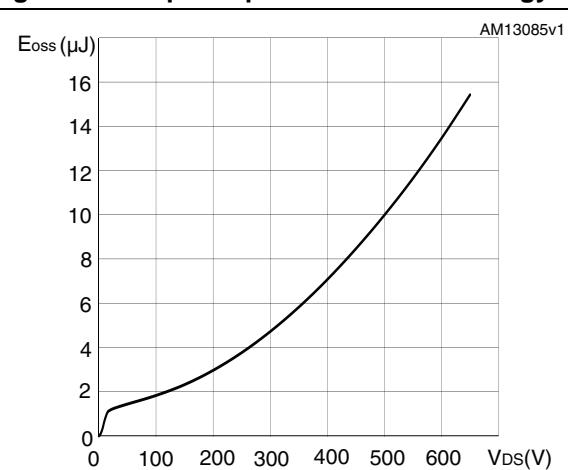
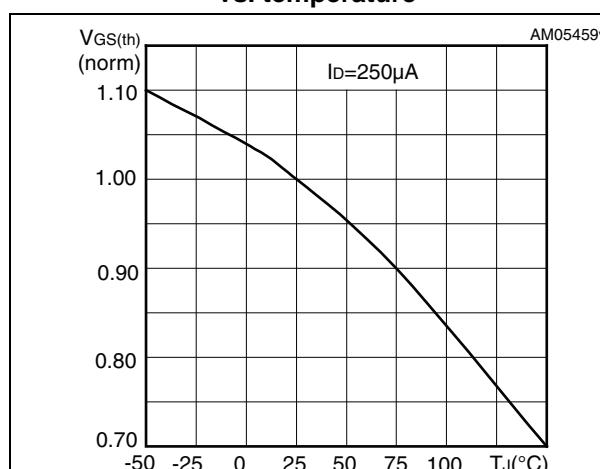
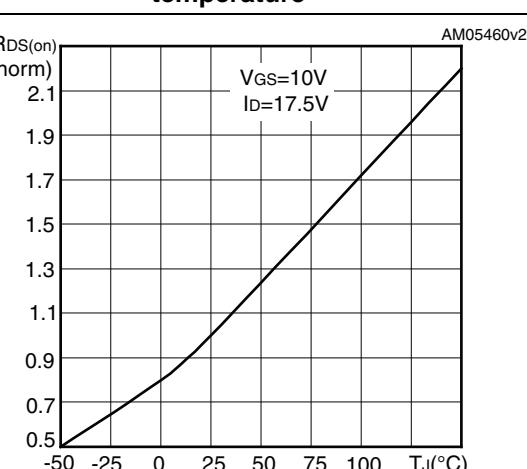
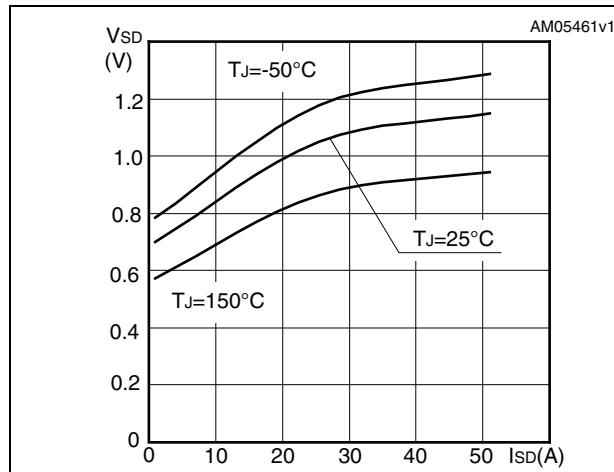
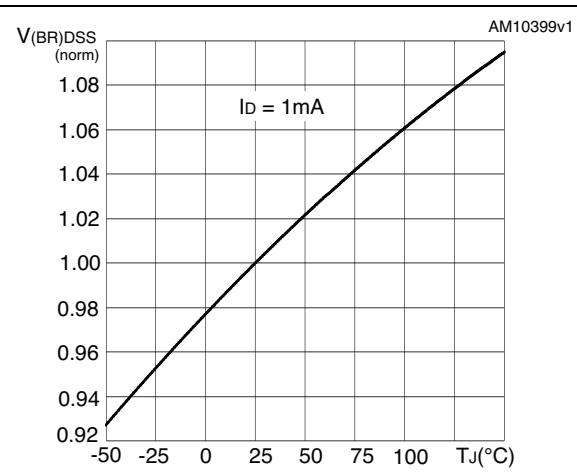
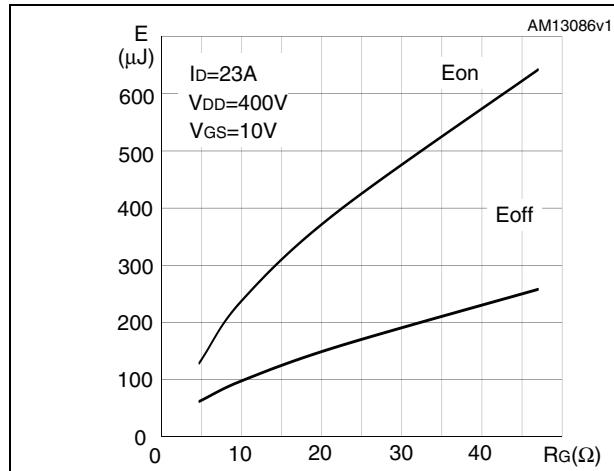


Figure 7. Transfer characteristics



**Figure 8. Gate charge vs gate-source voltage****Figure 9. Static drain-source on-resistance****Figure 10. Capacitance variations****Figure 11. Output capacitance stored energy****Figure 12. Normalized gate threshold voltage vs. temperature****Figure 13. Normalized on-resistance vs. temperature**

**Figure 14. Drain-source diode forward characteristics****Figure 15. Normalized  $V_{(BR)DSS}$  vs. temperature****Figure 16. Switching losses vs. gate resistance<sup>(1)</sup>**

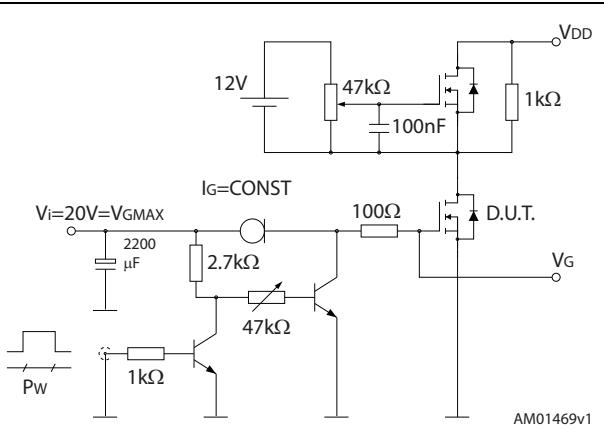
1.  $E_{on}$  including reverse recovery of a SiC diode

### 3 Test circuits

**Figure 17. Switching times test circuit for resistive load**



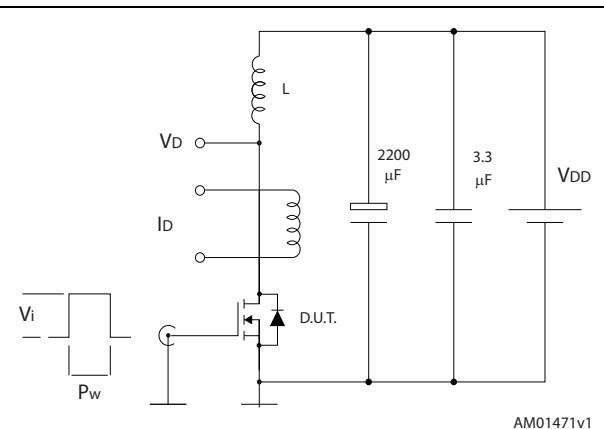
**Figure 18. Gate charge test circuit**



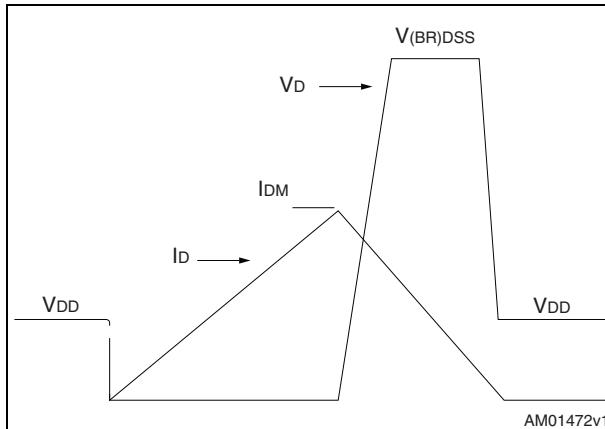
**Figure 19. Test circuit for inductive load switching and diode recovery times**



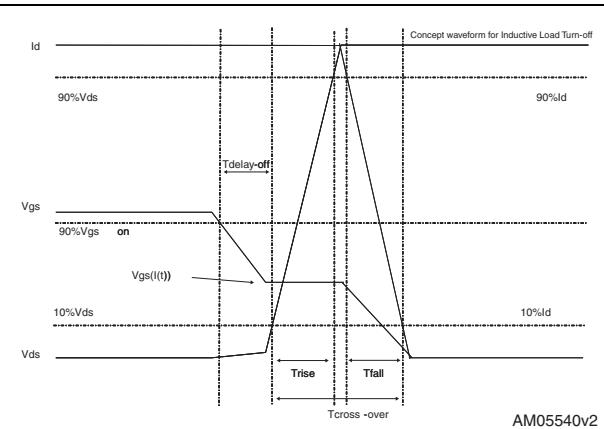
**Figure 20. Unclamped inductive load test circuit**



**Figure 21. Unclamped inductive waveform**



**Figure 22. Switching time waveform**

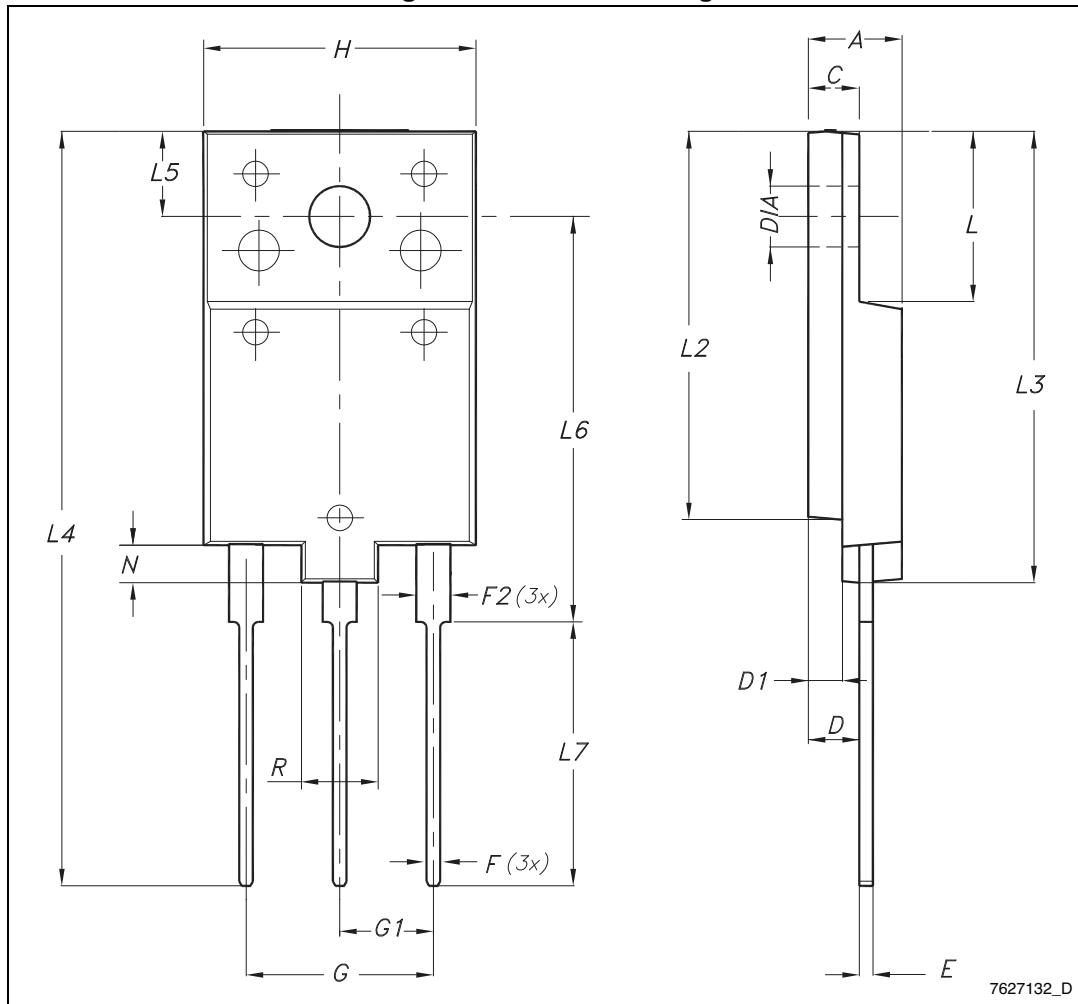


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK is an ST trademark.

## 4.1 TO-3PF, STFW45N65M5

Figure 23. TO-3PF drawing

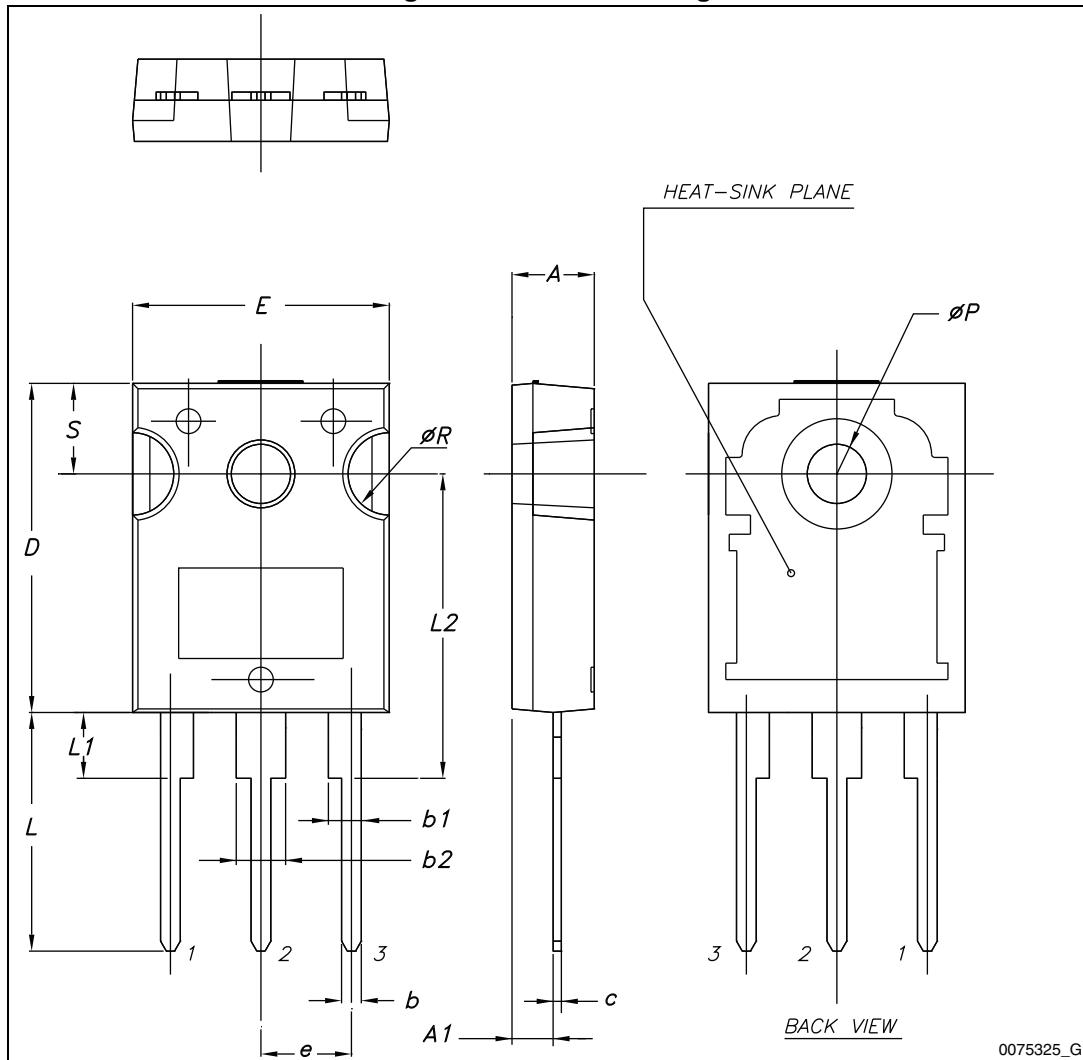


**Table 9. TO-3PF mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	5.30		5.70
C	2.80		3.20
D	3.10		3.50
D1	1.80		2.20
E	0.80		1.10
F	0.65		0.95
F2	1.80		2.20
G	10.30		11.50
G1		5.45	
H	15.30		15.70
L	9.80	10	10.20
L2	22.80		23.20
L3	26.30		26.70
L4	43.20		44.40
L5	4.30		4.70
L6	24.30		24.70
L7	14.60		15
N	1.80		2.20
R	3.80		4.20
Ø	3.40		3.80

## 4.2 TO-247, STW45N65M5

Figure 24. TO-247 drawing



0075325\_G

Table 10. TO-247 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

### 4.3 TO-247 long leads, STWA45N65M5

Figure 25. TO-247 long leads drawing

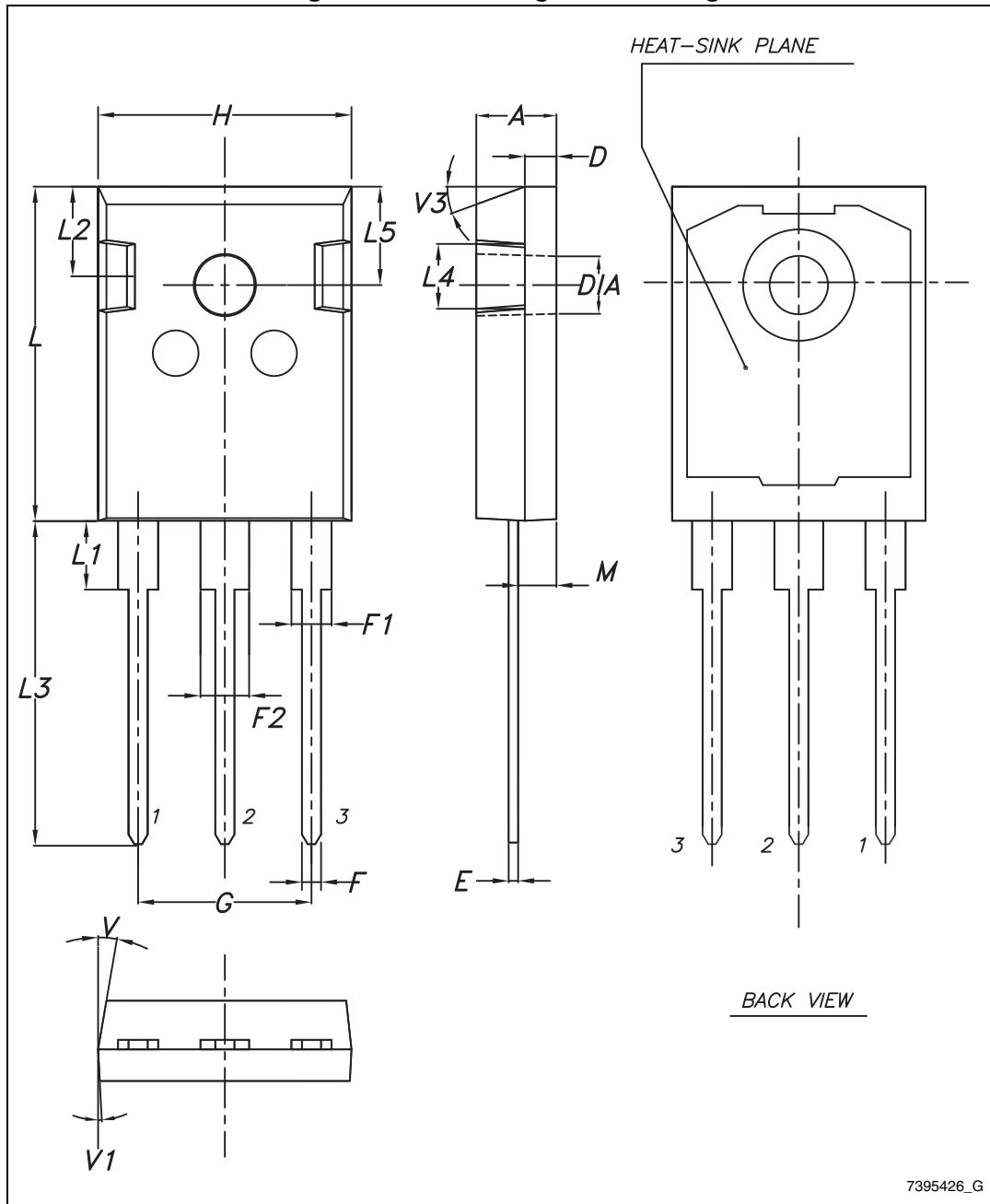


Table 11. TO-247 long leads mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.90		5.15
D	1.85		2.10
E	0.55		0.67
F	1.07		1.32
F1	1.90		2.38
F2	2.87		3.38
G	10.90 BSC		
H	15.77		16.02
L	20.82		21.07
L1	4.16		4.47
L2	5.49		5.74
L3	20.05		20.30
L4	3.68		3.93
L5	6.04		6.29
M	2.25		2.55
V		10°	
V1		3°	
V3		20°	
Dia.	3.55		3.66

## 5 Revision history

Table 12. Document revision history

Date	Revision	Changes
11-Dec-2012	1	First release.
09-May-2014	2	<ul style="list-style-type: none"><li>– Added: TO-3PF package</li><li>– Added: dv/dt (MOSFET dv/dt ruggedness) parameter and <math>V_{ISO}</math></li><li>– Modified: <a href="#">Figure 6</a> and <a href="#">7</a></li><li>– Minor text changes</li></ul>

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